


<b>Search Notes</b>  	<b>Application/Control No.</b>  10790814	<b>Applicant(s)/Patent Under Reexamination</b>  ZHANG ET AL.
	<b>Examiner</b>  Leff, Steven	<b>Art Unit</b>  1761

SEARCHED			
Class	Subclass	Date	Examiner
426	234, 113, 122, 118, 107, 243,	11/16/06	
219	732, 730	11/20/06	
99	dig. 14	11/15/06	
h05b006	64	11/17/06	

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

*Search Updated 1/3/08 SL*